# Aging Effects of As-deposited and Passivated Slanted Columnar Thin Films



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#### Results



(tilted 15°) and optical model equivalent



Spatially aligned, anisotropic inclusions with three major effective polarizabilities  $\mathbf{P}_{\text{eff},j}$  along principal axes  $j = \mathbf{a}, \mathbf{b}, \mathbf{c}$ (based on Bruggeman)

$$\sum_{n=1}^{m} f \frac{\varepsilon_n - \varepsilon_{\text{eff},j}}{\varepsilon_{\text{eff},j} + L_j(\varepsilon_n - \varepsilon_{\text{eff},j})} = 0$$

This model accounts for *m* different constituents with bulk-like optical constants  $\varepsilon_n$ . Depolarization factors  $L_j$ represent the biaxial film geometry. A projection matrix is applied to transform the virtual orthogonal basis into a monoclinic system.

D. Schmidt *et al.* Appl. Phys. Lett. **100**, 011912 (2012). K. B. Rodenhausen, D. Schmidt *et al.* Opt. Express **20**, 5419 (2012)

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#### **Best-Match Model Parameters**

Parameter	Co F1 (0 d)	Co F1 (after 60 d)	Co F1+Al <sub>2</sub> O <sub>3</sub> (0 d)	Co F1+Al <sub>2</sub> O <sub>3</sub> (after 60 d)
<i>t</i> (nm)	84.80(3)	84.88(4)	89.46(3)	89.86(3)
Θ (°)	62.52(1)	61.85(1)	62.69(1)	62.80(1)
β(°)	80.91(3)	84.21(2)	82.96(2)	83.39(2)
f <sub>void</sub> (%)	75.99(1)	77.44(1)	62.03(1)	59.33(6)
f <sub>Al2O3</sub> (%)			13.98(8)*	16.74(6)*
L <sup>D</sup> a	0.3983(1)	0.3817(1)	0.4035(2)	0.4030(2)
L <sup>D</sup> b	0.5134(1)	0.4469(1)	0.5267(2)	0.5283(2)
L <sup>D</sup> <sub>c</sub>	0.0884(3)	0.1714(4)	0.0698(7)	0.0688(6)
MSE	12.45	13.42	8.45	10.82

\*marginal changes are attributed to humidity changes  $\rightarrow$  very sensitive optical humidity sensor

**SEM Estimates** *r*<sub>avg</sub> = 11 nm (Co F1)

 $n_{\rm C} \approx 360 \text{ columns}/\mu m^2$ 

Ellipsometry Results  $n_{\rm C}$  = 302 columns/µm<sup>2</sup> surface area SA = 4.9 µm<sup>2</sup> surface area to volume ratio SA:V = 190 m<sup>-1</sup>

 $Al_2O_3$  thickness  $t_{AIO} = 2.80$  nm

 $Al_2O_3$  ALD with identical parameters on 100 nm solid Co reference sample results in a layer thickness  $t_{AlO}$  = 3.29 nm

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